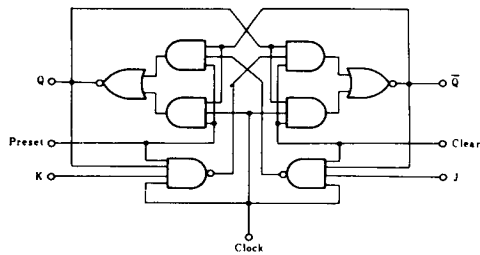
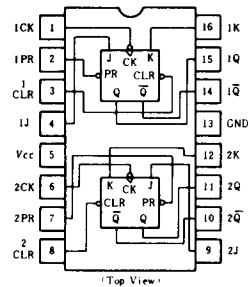


HD74LS76A • Dual J-K Flip-Flops (with Preset and Clear)

■ BLOCK DIAGRAM (1/2)



■ PIN ARRANGEMENT

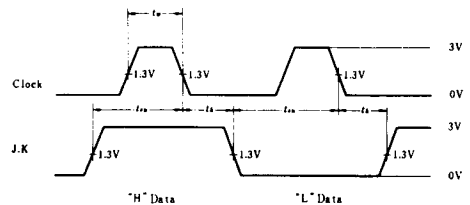


■ RECOMMENDED OPERATING CONDITIONS

Item	Symbol	min	typ	max	Unit
Clock frequency	f_{clock}	0	—	30	MHz
Pulse width	Clock High	20	—	—	ns
	Clear Preset Low	25	—	—	
Setup time	"H" Data	20	—	—	ns
	"L" Data	20	—	—	
Hold time	t_h	0	—	—	ns

Note) ↓; The arrow indicates the falling edge.

■ TIMING DEFINITION



■ ELECTRICAL CHARACTERISTICS ($T_a = -20 \sim +75^\circ\text{C}$)

Item		Symbol	Test Conditions	min	typ*	max	Unit	
Input voltage		V_{IH}		2.0	—	—	V	
		V_{IL}		—	—	0.8	V	
Output voltage		V_{OH}	$V_{CC}=4.75\text{V}$, $V_{IH}=2\text{V}$, $V_{IL}=0.8\text{V}$, $I_{OH}=-400\mu\text{A}$	2.7	—	—	V	
		V_{OL}	$V_{CC}=4.75\text{V}$, $V_{IH}=2\text{V}$, $V_{IL}=0.8\text{V}$	$I_{OL}=8\text{mA}$	—	—	0.5	V
				$I_{OL}=4\text{mA}$	—	—	0.4	
Input current	J, K	I_{IH}	$V_{CC}=5.25\text{V}$, $V_I=2.7\text{V}$	—	—	20	μA	
	Clear			—	—	60		
	Preset			—	—	60		
	Clock			—	—	80		
	J, K	I_{IL}^{**}	$V_{CC}=5.25\text{V}$, $V_I=0.4\text{V}$	—	—	-0.4	mA	
	Clear			—	—	-0.8		
	Preset			—	—	-0.8		
	Clock			—	—	-0.8		
	J, K	I_I	$V_{CC}=5.25\text{V}$, $V_I=7\text{V}$	—	—	0.1	mA	
	Clear			—	—	0.3		
	Preset			—	—	0.3		
	Clock			—	—	0.4		
Short-circuit output current		I_{OS}	$V_{CC}=5.25\text{V}$	-20	—	-100	mA	
Supply current ***		I_{CC}	$V_{CC}=5.25\text{V}$	—	4	6	mA	
Input clamp voltage		V_{IK}	$V_{CC}=4.75\text{V}$, $I_{IN}=-18\text{mA}$	—	—	-1.5	V	

* $V_{CC} = 5\text{V}$, $T_a = 25^\circ\text{C}$

** I_{IL} should not be measured when preset and clear inputs are low at same time.

*** With all outputs open, I_{CC} is measured with the Q and $\bar{Q}$ outputs high in turn. At the time of measurement, the clock input is grounded.

FUNCTION TABLE

Inputs					Outputs	
Preset	Clear	Clock	J	K	Q	$\bar{Q}$
L	H	X	X	X	H	L
H	L	X	X	X	L	H
L	L	X	X	X	H*	H*
H	H	↓	L	L	Q ₀	$\bar{Q}_0$
H	H	↓	H	L	H	L
H	H	↓	L	H	L	H
H	H	↓	H	H	Toggle	
H	H	H	X	X	Q ₀	$\bar{Q}_0$

Notes) H; high level, L; low level, X; irrelevant

↓; transition from high to low level

Q₀; level of Q before the indicated steady-state input conditions were established.

$\bar{Q}_0$; complement of Q₀ or level of $\bar{Q}$ before the indicated steady-state input conditions were established.

Toggle; each output changes to the complement of its previous level on each active transition indicated by ↓.

*; This configuration is nonstable; that is, it will not persist when preset and clear inputs return to their inactive (high) level.

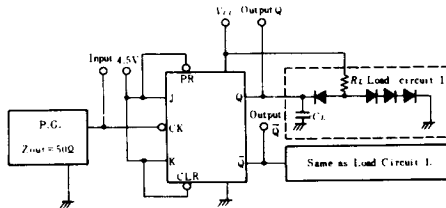
SWITCHING CHARACTERISTICS (V_{CC}=5V, T_a=25°C)

Item	Symbol	Inputs	Outputs	Test Conditions	min	typ	max	Unit
Maximum clock frequency	f _{max}				30	45	—	MHz
Propagation delay time	t _{PLH}	Clear	Q, $\bar{Q}$	C _L =15pF, R _L =2kΩ	—	15	20	ns
	t _{PHL}	Preset			—	15	20	ns

TESTING METHOD

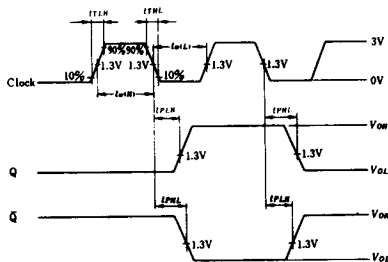
1) Test Circuit

1.1) f_{max}, t_{PLH}, t_{PHL} (Clock → Q, $\bar{Q}$)



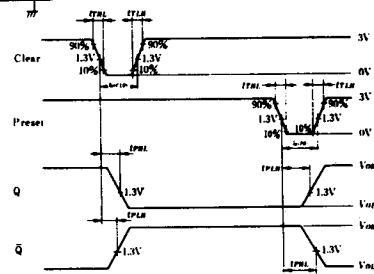
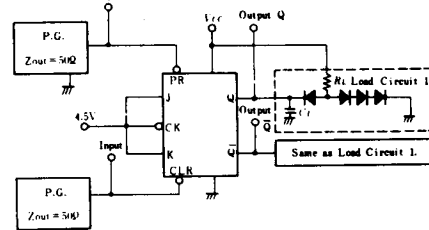
- Notes) 1. Test is put into the each flip-flop
2. All diodes are 1S2074 (D).
3. C_L includes probe and jig capacitance.

Waveform



Note) Clock input pulse; t_{TLH} ≤ 15ns, t_{THL} ≤ 6ns, PRR = 1MHz, duty cycle = 50% and; for f_{max}, t_{TLH} = t_{THL} ≤ 2.5ns.

1.2) t_{PHL}, t_{PLH} (Clear, Preset → Q, $\bar{Q}$)



Note) Clear and preset input pulse; t_{TLH} ≤ 15ns, t_{THL} ≤ 6ns, PRR = 1MHz



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